

FEATURES

- High saturated output power (P_{SAT}): 41.5 dBm typical
- High small signal gain: 35 dB typical
- High power gain for saturated output power: 25.5 dB typical
- Bandwidth: 2.7 GHz to 3.8 GHz
- High power added efficiency (PAE): 54% typical
- High output IP3: 44 dBm typical
- Supply voltage: $V_{DD} = 28$ V at 150 mA
- 32-lead, 5 mm × 5 mm LFCSP_CAV package

APPLICATIONS

- Extended battery operation for public mobile radios
- Power amplifier stage for wireless infrastructure
- Test and measurement equipment
- Commercial and military radars
- General-purpose transmitter amplification

GENERAL DESCRIPTION

The **HMC1114** is a gallium nitride (GaN), broadband power amplifier, delivering 10 W with more than 50% power added efficiency (PAE) across a bandwidth of 2.7 GHz to 3.8 GHz. The **HMC1114** provides ± 0.5 dB gain flatness.

FUNCTIONAL BLOCK DIAGRAM

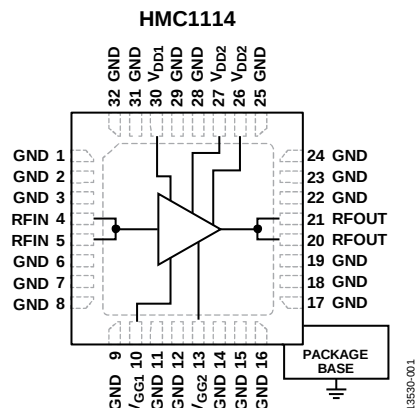


Figure 1.

The **HMC1114** is ideal for pulsed or continuous wave (CW) applications such as wireless infrastructure, radar, public mobile radio, and general-purpose amplification.

The **HMC1114** is housed in a compact LFCSP_CAV package.

HMC1114* Product Page Quick Links

Last Content Update: 11/01/2016

Comparable Parts

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Evaluation Kits

- HMC1114 Evaluation Board

Documentation

Data Sheet

- HMC1114: 10 Watt, GaN Power Amplifier, 2.7 GHz to 3.8 GHz Data Sheet

Design Resources

- HMC1114 Material Declaration
- PCN-PDN Information
- Quality And Reliability
- Symbols and Footprints

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TABLE OF CONTENTS

Features	1	Interface Schematics	5
Applications	1	Typical Performance Characteristics	6
Functional Block Diagram	1	Theory of Operation	12
General Description	1	Applications Information	13
Revision History	2	Recommended Bias Sequence	13
Specifications.....	3	Typical Application Circuit.....	13
Electrical Specifications.....	3	Evaluation Printed Circuit Board (PCB).....	14
Total Supply Current by V _{DD}	3	Bill of Materials.....	14
Absolute Maximum Ratings.....	4	Outline Dimensions	15
ESD Caution.....	4	Ordering Guide	15
Pin Configuration and Function Descriptions.....	5		

REVISION HISTORY

9/2016—Revision 0: Initial Version

SPECIFICATIONS

ELECTRICAL SPECIFICATIONS

$T_A = 25^\circ\text{C}$, $V_{DD} = 28\text{ V}$, $I_{DQ} = 150\text{ mA}$, frequency range = 2.7 GHz to 3.2 GHz, unless otherwise noted.

Table 1.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
FREQUENCY RANGE		2.7		3.2	GHz	
GAIN						
Small Signal Gain		32	35		dB	
Gain Flatness			± 0.5		dB	
Power Gain for 4 dB Compression			29		dB	
Power Gain for Saturated Output Power			25.5		dB	Measurement taken at $P_{IN} = 16\text{ dBm}$
RETURN LOSS						
Input			14		dB	
Output			11		dB	
POWER						
Output Power for 4 dB Compression	P_{4dB}		39		dBm	
Saturated Output Power	P_{SAT}		41.5		dBm	Measurement taken at $P_{IN} = 16\text{ dBm}$
Power Added Efficiency	PAE		54		%	
OUTPUT THIRD-ORDER INTERCEPT	IP3		44			Measurement taken at $P_{OUT}/\text{tone} = 30\text{ dBm}$
TARGET QUIESCENT CURRENT	I_{DQ}		150		mA	Adjust the gate control voltage (V_{GG1} , V_{GG2}) between -8 V and 0 V to achieve an $I_{DQ} = 150\text{ mA}$ typical

$T_A = 25^\circ\text{C}$, $V_{DD} = 28\text{ V}$, $I_{DQ} = 150\text{ mA}$, frequency range = 3.2 GHz to 3.8 GHz, unless otherwise noted.

Table 2.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
FREQUENCY RANGE		3.2		3.8	GHz	
GAIN						
Small Signal Gain		29	32		dB	
Gain Flatness			± 1		dB	
Power Gain for 4 dB Compression			28		dB	
Power Gain for Saturated Output Power			25		dB	Measurement taken at $P_{IN} = 16\text{ dBm}$
RETURN LOSS						
Input			25		dB	
Output			9		dB	
POWER						
Output Power for 4 dB Compression	P_{4dB}		40		dBm	
Saturated Output Power	P_{SAT}		40.5		dBm	Measurement taken at $P_{IN} = 16\text{ dBm}$
Power Added Efficiency	PAE		53		%	
OUTPUT THIRD-ORDER INTERCEPT	IP3		44			Measurement taken at $P_{OUT}/\text{tone} = 30\text{ dBm}$
TARGET QUIESCENT CURRENT	I_{DQ}		150		mA	Adjust the gate control voltage (V_{GG1} , V_{GG2}) between -8 V and 0 V to achieve an $I_{DQ} = 150\text{ mA}$ typical

TOTAL SUPPLY CURRENT BY V_{DD}

Table 3.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
SUPPLY CURRENT	I_{DQ}					Adjust V_{GG1} , V_{GG2} to achieve an $I_{DQ} = 150\text{ mA}$ typical
$V_{DD} = 25\text{ V}$			150		mA	
$V_{DD} = 28\text{ V}$			150		mA	
$V_{DD} = 32\text{ V}$			150		mA	

ABSOLUTE MAXIMUM RATINGS

Table 4.

Parameter	Rating
Drain Bias Voltage (V_{DD1} , V_{DD2})	35 V dc
Gate Bias Voltage (V_{GG1} , V_{GG2})	–8 V to 0 V dc
RF Input Power (RFIN)	30 dBm
Maximum Forward Gate Current	4 mA
Continuous Power Dissipation, P_{DISS} ($T_A = 85^\circ\text{C}$, Derate 227 mW/ $^\circ\text{C}$ Above 120 $^\circ\text{C}$)	24 W
Thermal Resistance, Junction to Back of Paddle	4.4 $^\circ\text{C}/\text{W}$
Channel Temperature	225 $^\circ\text{C}$
Maximum Peak Reflow Temperature (MSL3) ¹	260 $^\circ\text{C}$
Storage Temperature Range	–40 $^\circ\text{C}$ to +125 $^\circ\text{C}$
Operating Temperature Range	–40 $^\circ\text{C}$ to +85 $^\circ\text{C}$
ESD Sensitivity (Human Body Model)	Class 1A, passed 250 V

¹ See the Ordering Guide section.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

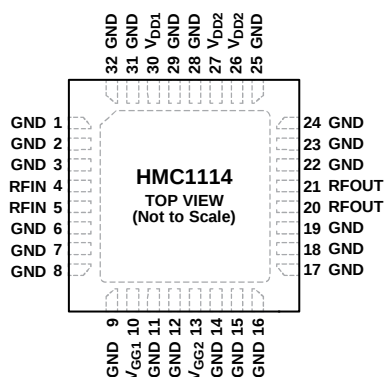
ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



NOTES
1. EXPOSED PAD. EXPOSED PAD MUST BE CONNECTED TO RF/DC GROUND.

13530-002

Figure 2. Pin Configuration

Table 5. Pin Function Descriptions

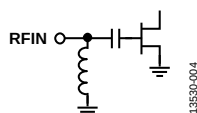
Pin No.	Mnemonic	Description
1 to 3, 6 to 9, 11, 12, 14 to 19, 22 to 25, 28, 29, 31, 32	GND	Ground. These pins and the package bottom (EPAD) must be connected to RF/dc ground. See Figure 3 for the GND interface schematic.
4, 5	RFIN	RF Input. These pins are dc-coupled and matched to 50 Ω . See Figure 4 for the RFIN interface schematic.
10, 13	V _{GG1} , V _{GG2}	Gate Control Voltage Pins. External bypass capacitors of 1 μ F and 10 μ F are required. See Figure 5 for the V _{GG1} and V _{GG2} interface schematic.
20, 21	RFOUT	RF Output. These pins are ac-coupled and matched to 50 Ω . See Figure 6 for the RFOUT interface schematic.
26, 27, 30	V _{DD1} , V _{DD2}	Drain Bias Pins for the Amplifier. External bypass capacitors of 100 pF, 1 μ F, and 10 μ F are required. See Figure 7 for the V _{DD1} and V _{DD2} interface schematic.
	EPAD	Exposed Pad. The exposed pad must be connected to RF/dc ground.

INTERFACE SCHEMATICS



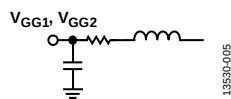
13530-003

Figure 3. GND Interface



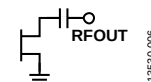
13530-004

Figure 4. RFIN Interface



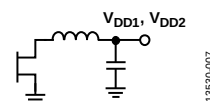
13530-005

Figure 5. V_{GG1} and V_{GG2} Interface



13530-006

Figure 6. RFOUT Interface



13530-007

Figure 7. V_{DD1} and V_{DD2} Interface

TYPICAL PERFORMANCE CHARACTERISTICS

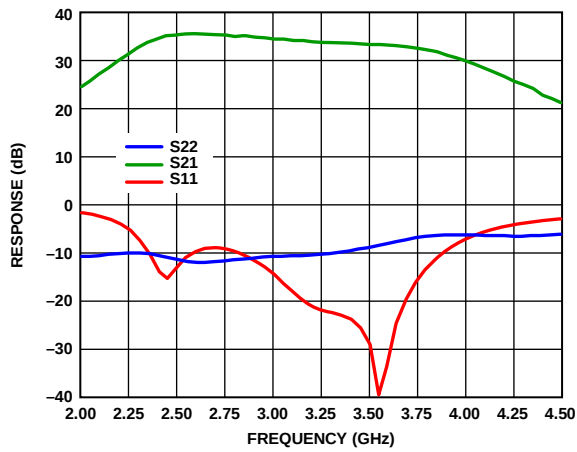


Figure 8. Response (Gain and Return Loss) vs. Frequency

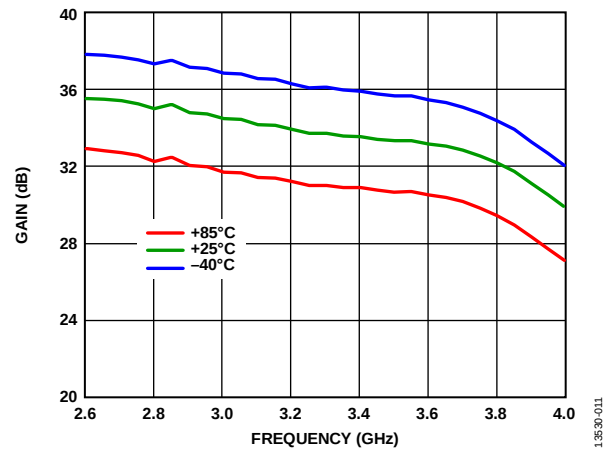


Figure 11. Gain vs. Frequency at Various Temperatures

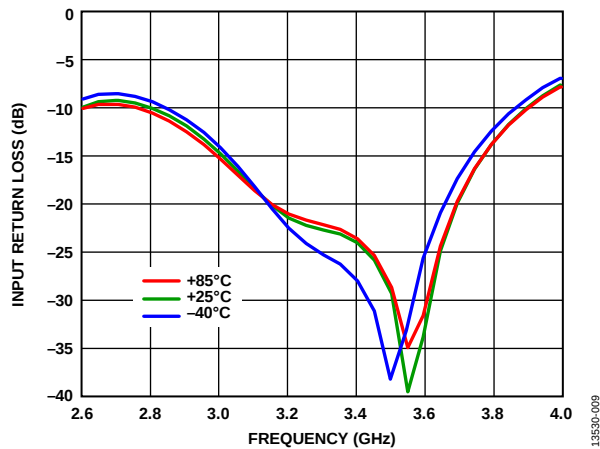


Figure 9. Input Return Loss vs. Frequency at Various Temperatures

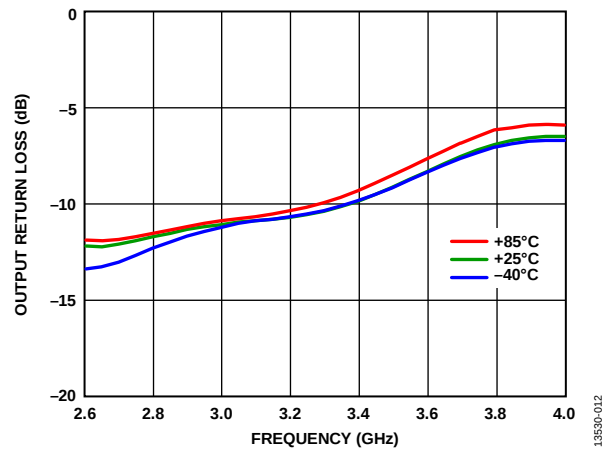


Figure 12. Output Return Loss vs. Frequency at Various Temperatures

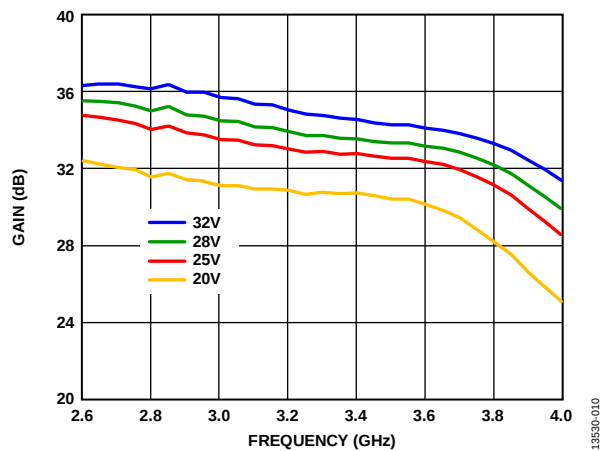


Figure 10. Gain vs. Frequency at Various Supply Voltages

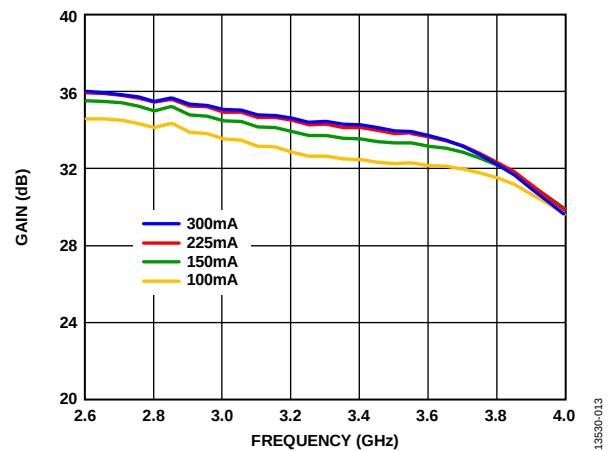


Figure 13. Gain vs. Frequency at Various Supply Currents

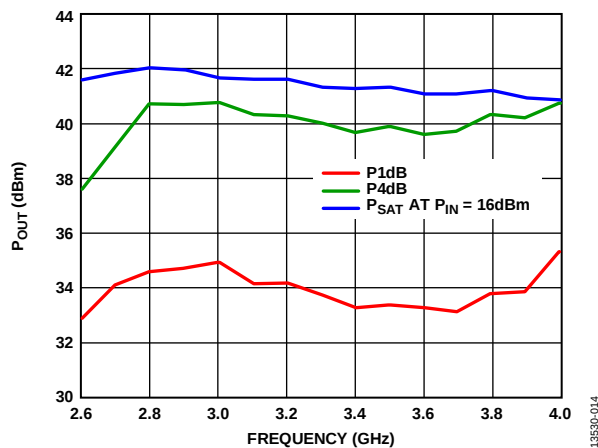


Figure 14. Output Power (P_{OUT}) vs. Frequency, Measurement Taken at $P_{IN} = 16$ dBm

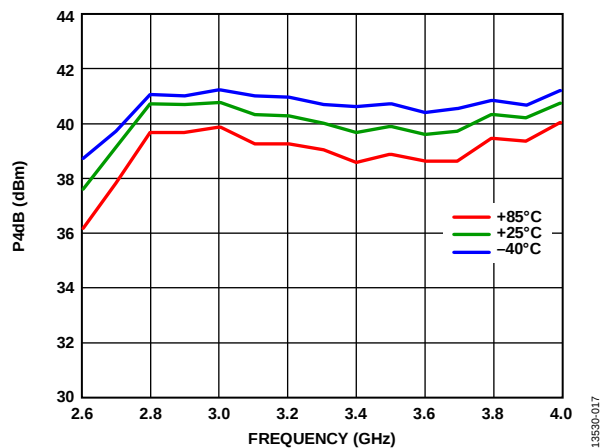


Figure 17. Output Power for 4 dB Compression (P_{4dB}) vs. Frequency at Various Temperatures

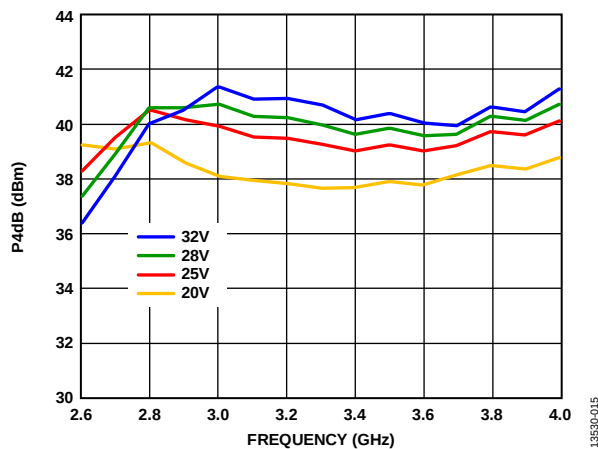


Figure 15. Output Power for 4 dB Compression (P_{4dB}) vs. Frequency at Various Supply Voltages

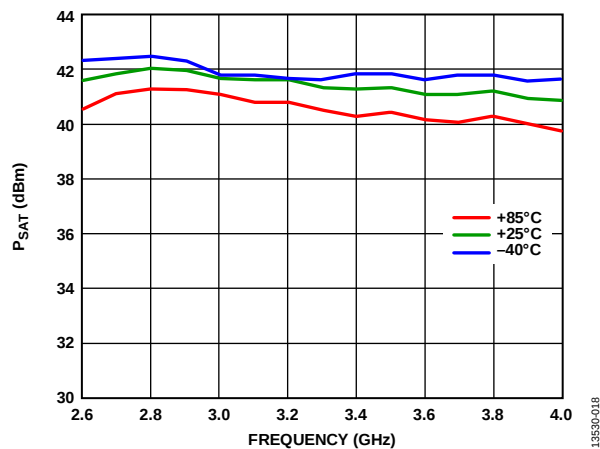


Figure 18. Saturated Output Power (P_{SAT}) vs. Frequency at Various Temperatures, Measurement Taken at $P_{IN} = 16$ dBm

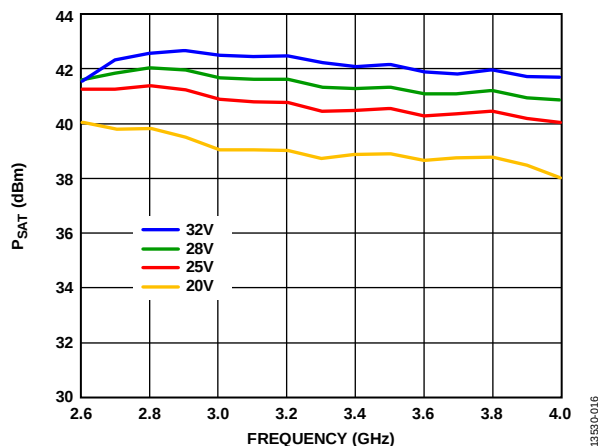


Figure 16. Saturated Output Power (P_{SAT}) vs. Frequency at Various Supply Voltages, Measurement Taken at $P_{IN} = 16$ dBm

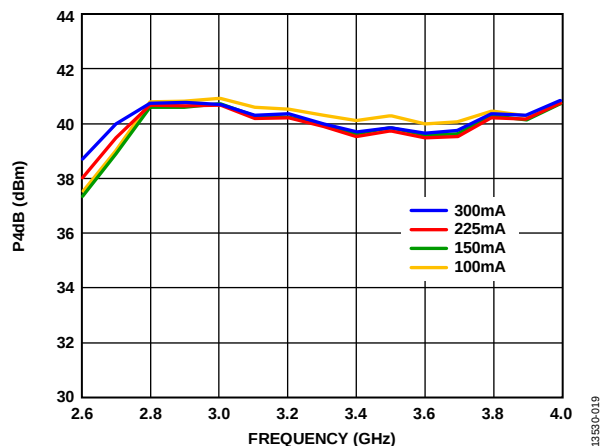


Figure 19. Output Power for 4 dB Compression (P_{4dB}) vs. Frequency at Various Supply Currents

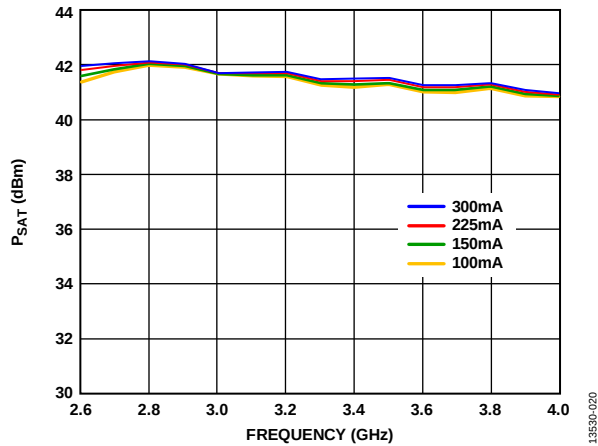


Figure 20. Saturated Output Power (P_{SAT}) vs. Frequency at Various Supply Currents, Measurement Taken at $P_{IN} = 16$ dBm

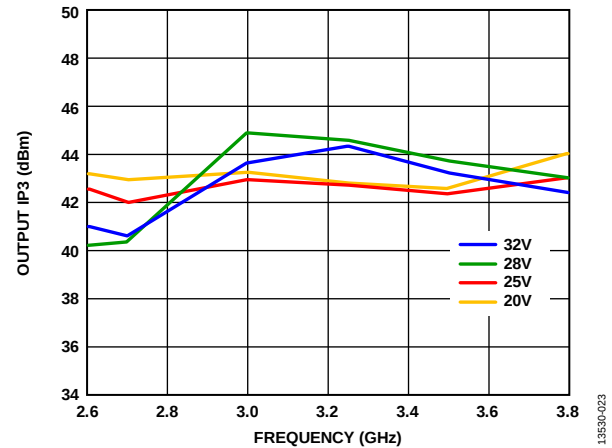


Figure 23. Output Third-Order Intercept (IP3) vs. Frequency at Various Supply Voltages, $P_{OUT}/Tone = 30$ dBm

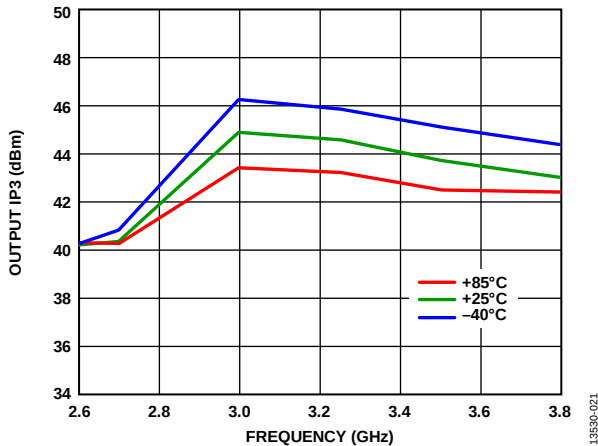


Figure 21. Output Third-Order Intercept (IP3) vs. Frequency at Various Temperatures, $P_{OUT}/Tone = 30$ dBm

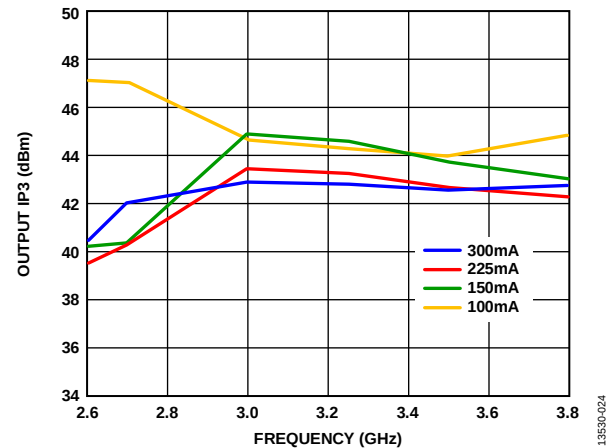


Figure 24. Output Third-Order Intercept (IP3) vs. Frequency at Various Supply Currents, $P_{OUT}/Tone = 30$ dBm

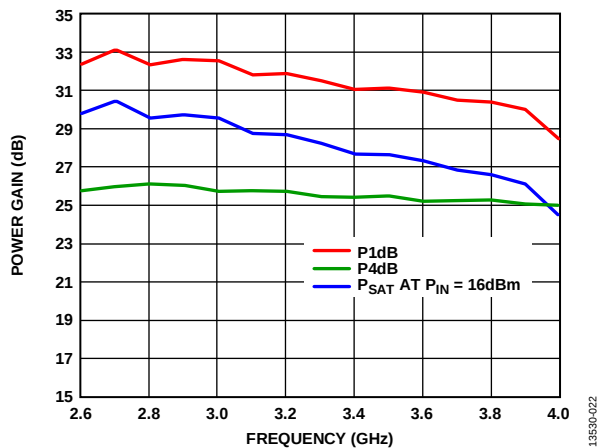


Figure 22. Power Gain vs. Frequency

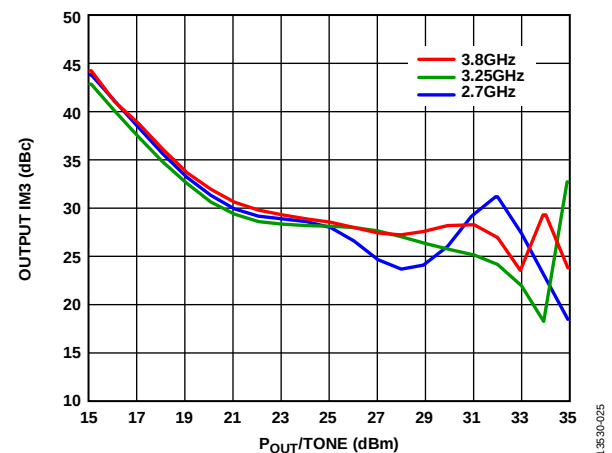
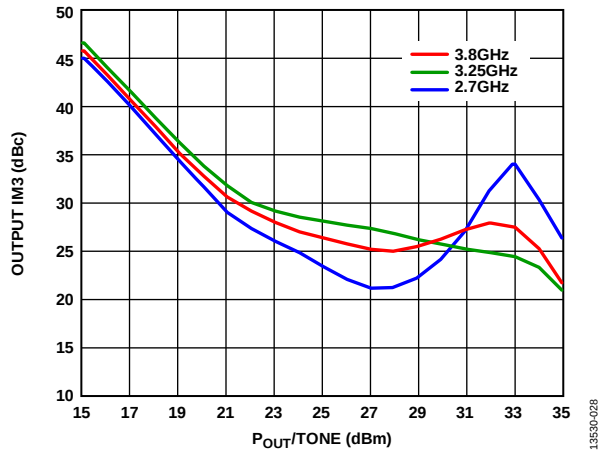
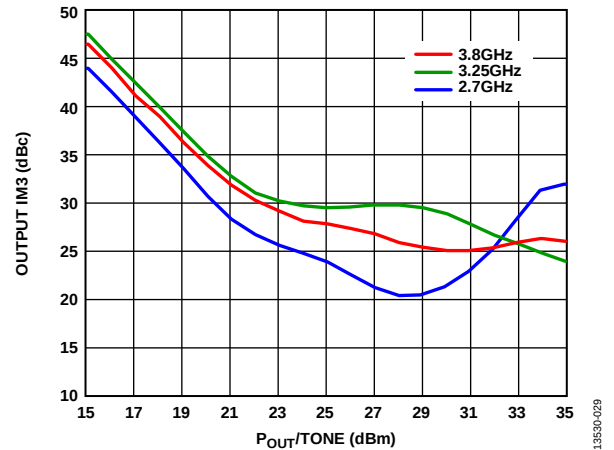
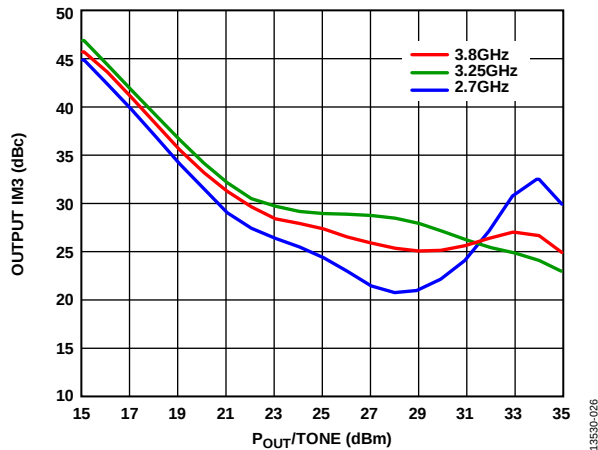
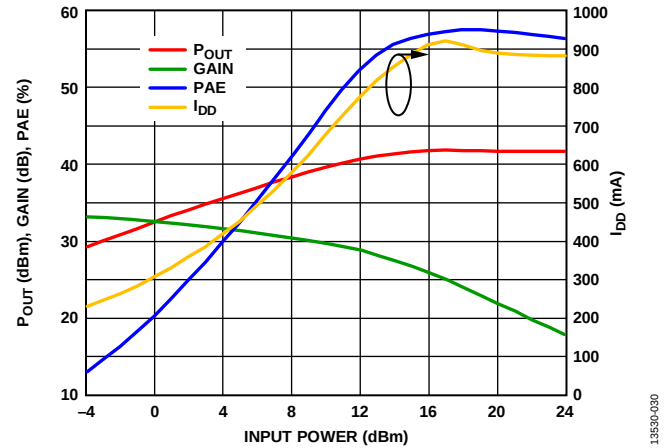
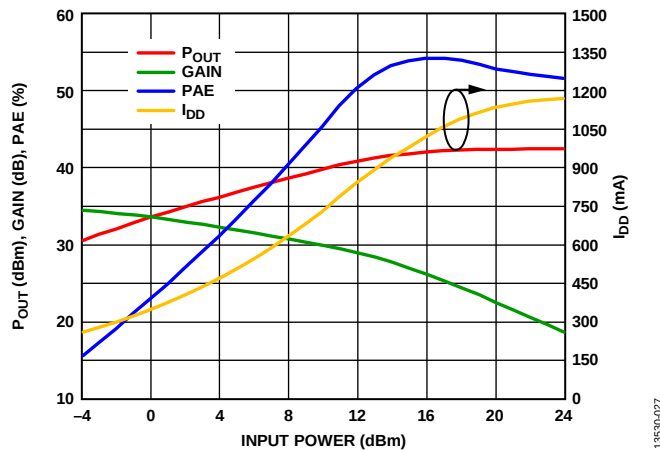
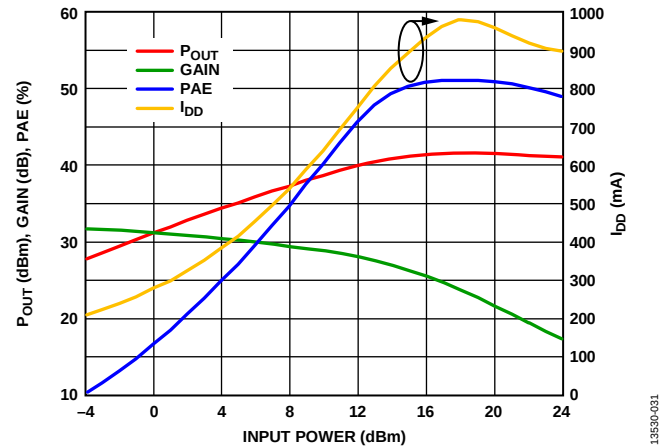


Figure 25. Output Third-Order Intermodulation (IM3) vs. $P_{OUT}/Tone$ at $V_{DD} = 20$ V

Figure 26. Output Third-Order Intermodulation (IM3) vs. $P_{OUT}/Tone$ at $V_{DD} = 25\text{ V}$ Figure 29. Output Third-Order Intermodulation (IM3) vs. $P_{OUT}/Tone$ at $V_{DD} = 32\text{ V}$ Figure 27. Output Third-Order Intermodulation (IM3) vs. $P_{OUT}/Tone$ at $V_{DD} = 28\text{ V}$ Figure 30. Output Power (P_{OUT}), Gain, Power Added Efficiency (PAE), and Supply Current (I_{DD}) vs. Input Power at 3.2 GHzFigure 28. Output Power (P_{OUT}), Gain, Power Added Efficiency (PAE), and Supply Current (I_{DD}) vs. Input Power at 2.7 GHzFigure 31. Output Power (P_{OUT}), Gain, Power Added Efficiency (PAE), and Supply Current (I_{DD}) vs. Input Power at 3.8 GHz

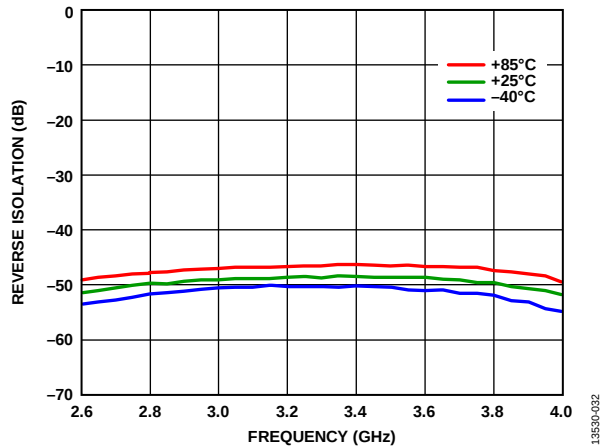


Figure 32. Reverse Isolation vs. Frequency at Various Temperatures

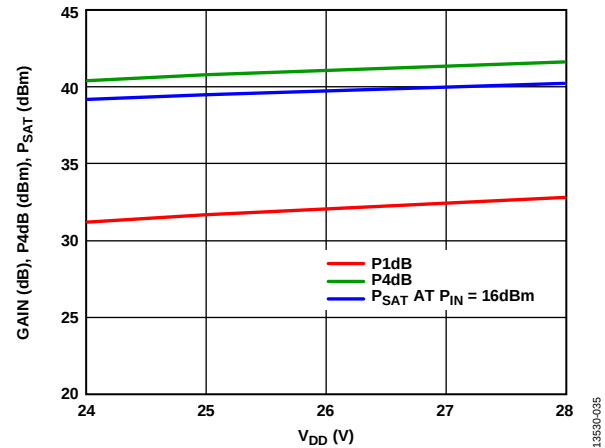
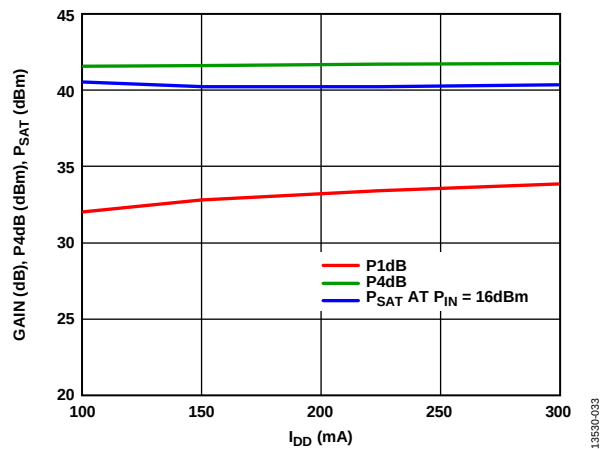
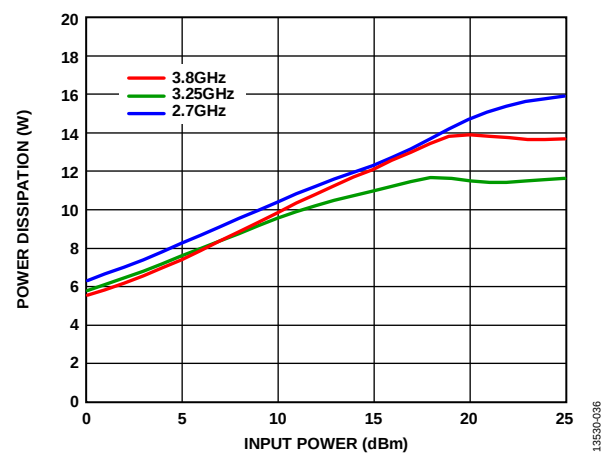
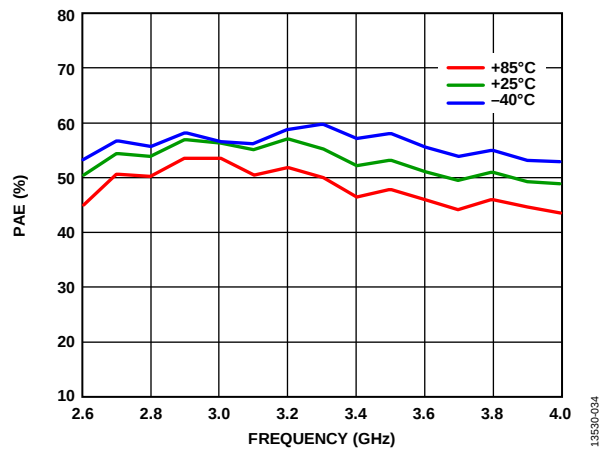
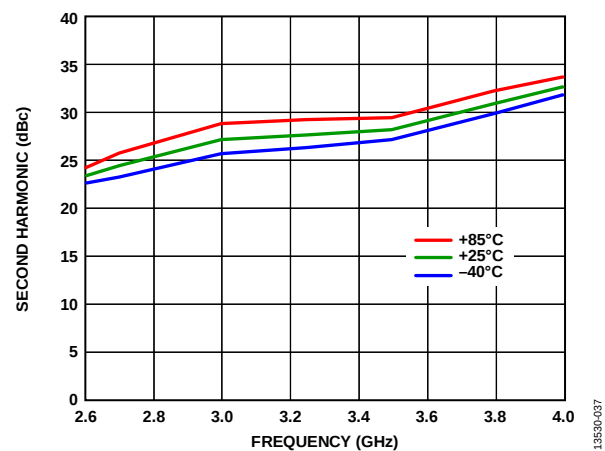
Figure 35. Gain, P4dB, and P_{SAT} vs. Supply Voltage (V_{DD}) at 3.2 GHzFigure 33. Gain, Output Power for 4 dB Compression (P_{4dB}), and Saturated Output Power (P_{SAT}) vs. Supply Current (I_{DD})

Figure 36. Power Dissipation vs. Input Power at 85°C

Figure 34. Power Added Efficiency (PAE) vs. Frequency at Various Temperatures, $P_{IN} = 16$ dBmFigure 37. Second Harmonic vs. Frequency at Various Temperatures, $P_{OUT} = 30$ dBm

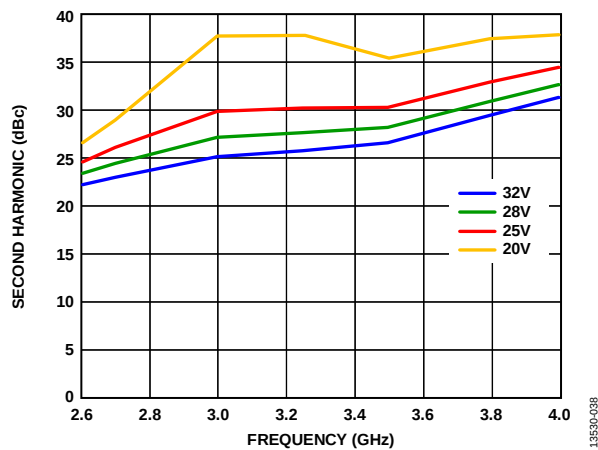


Figure 38. Second Harmonic vs. Frequency at Various Supply Voltages, $P_{OUT} = 30$ dBm

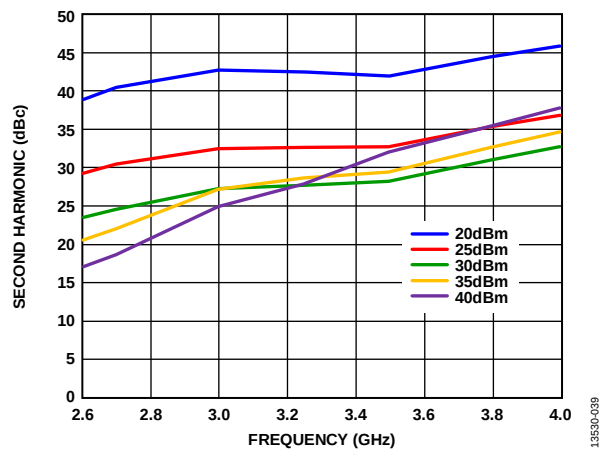


Figure 39. Second Harmonic vs. Frequency at Various Output Powers

THEORY OF OPERATION

The **HMC1114** is a 10 W, gallium nitride (GaN), power amplifier that consists of two gain stages in series, and the basic block diagram for the amplifier is shown in Figure 40.

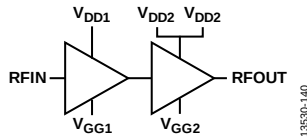


Figure 40. Basic Block Diagram

The recommended dc bias conditions put the device in deep Class AB operation, resulting in high P_{SAT} (41.5 dBm typical) at improved levels of PAE (54% typical). The voltage applied to the V_{GG1} and V_{GG2} pads sets the gate bias of the field effect transistors (FETs), providing control of the drain current. For this reason, the application of a bias voltage to the V_{GG1} and V_{GG2} pads is required and not optional.

The **HMC1114** has single-ended input and output ports whose impedances are nominally equal to $50\ \Omega$ over the 2.7 GHz to 3.8 GHz frequency range. Consequently, it can directly insert into a $50\ \Omega$ system with no required impedance matching circuitry, which also means that multiple **HMC1114** amplifiers can be cascaded back to back without the need for external matching circuitry. The input and output impedances are sufficiently stable vs. variations in temperature and supply voltage that no impedance matching compensation is required.

Note that it is critical to supply very low inductance ground connections to the GND pins and the package base exposed pad to ensure stable operation. To achieve optimal performance from the **HMC1114** and prevent damage to the device, do not exceed the absolute maximum ratings.

EVALUATION PRINTED CIRCUIT BOARD (PCB)

The [EVL1HMC1114LP5D](#) (600-01209-00) evaluation PCB is shown in Figure 42.

BILL OF MATERIALS

Use RF circuit design techniques for the circuit board used in the application. Provide 50 Ω impedance for the signal lines and

directly connect the package ground leads and exposed paddle to the ground plane, similar to that shown in Figure 42. Use a sufficient number of via holes to connect the top and bottom ground planes. The evaluation PCB shown in Figure 42 is available from Analog Devices, Inc., upon request.

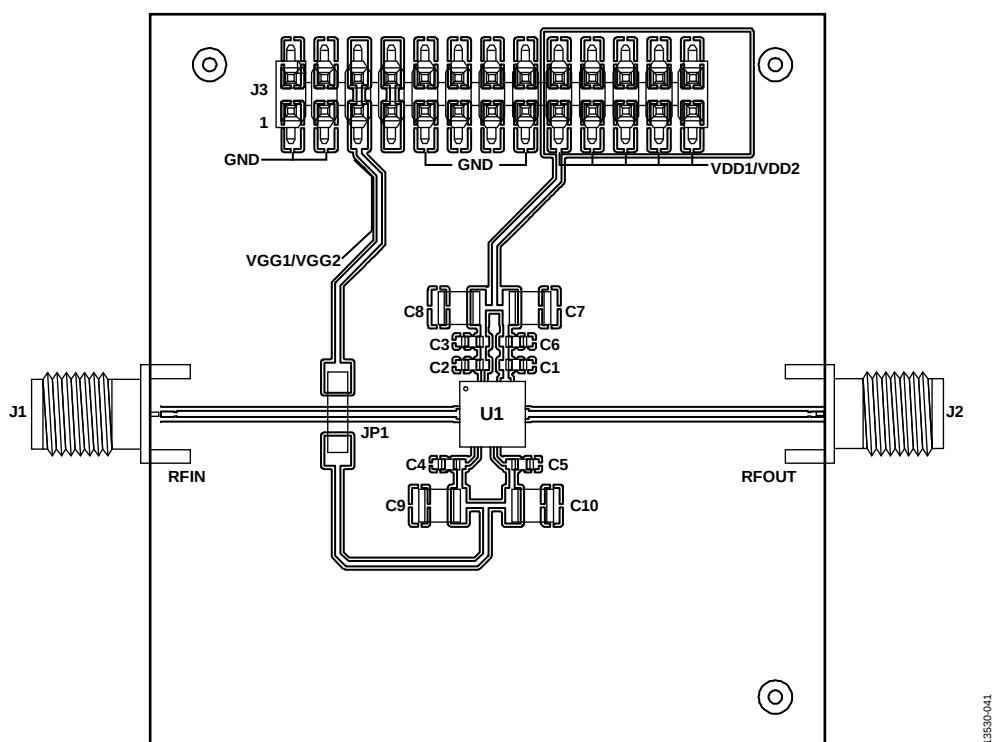


Figure 42. Evaluation Printed Circuit Board (PCB)

134330-041

Table 6. Bill of Materials for Evaluation PCB [EVL1HMC1114LP5D](#) (600-01209-00)

Item	Description
J1, J2	SMA connectors
J3	DC pins
JP1	Preform jumper
C1, C2	1000 pF capacitors, 0603 package
C3 to C6	1 μ F capacitors, 0603 package
C7 to C10	10 μ F capacitors, 1210 package
U1	HMC1114LP5DE
PCB	600-01209-00 evaluation PCB; circuit board material: Rogers 4350 or Arlon 25FR

OUTLINE DIMENSIONS

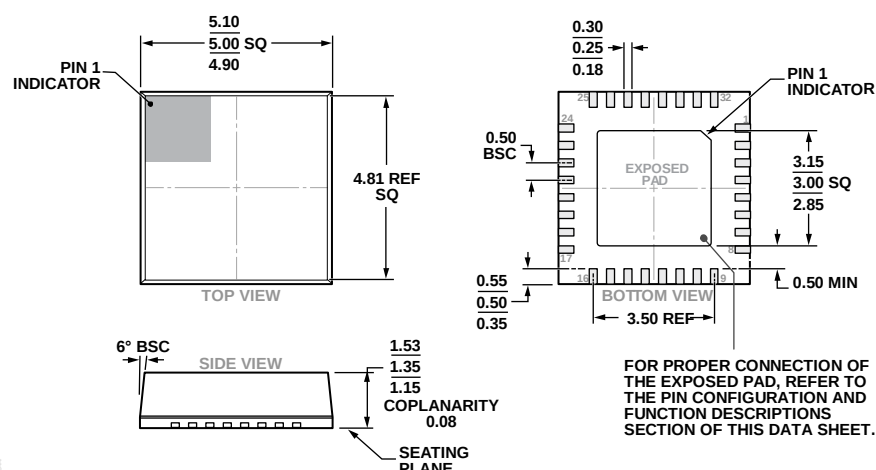


Figure 43. 32-Lead Lead Frame Chip Scale Package, Premolded Cavity [LFCSP_CAV]
5 mm x 5 mm Body and 1.34 mm Package Height
(CG-32-1)
Dimensions shown in millimeters

ORDERING GUIDE

Model ^{1,2}	Temperature	MSL Rating ³	Description ⁴	Package Option	Package Marking ⁵
HMC1114LP5DE	−40°C to +85°C	MSL3	32-Lead Lead Frame Chip Scale Package, Premolded Cavity [LFCSP_CAV]	CG-32-1	H1114 XXXX
HMC1114LP5DETR	−40°C to +85°C	MSL3	32-Lead Lead Frame Chip Scale Package, Premolded Cavity [LFCSP_CAV]	CG-32-1	H1114 XXXX
EVL1HMC1114LP5D			Evaluation Board		

¹ The HMC1114LP5DE and the HMC1114LP5DETR are LFCSP premolded copper alloy lead frame and RoHS Compliant Parts.

² When ordering the evaluation board only, reference the EVL1HMC1114LP5D model number.

³ See the Absolute Maximum Ratings section for additional information.

⁴ The lead finish of the HMC1114LP5DE and HMC1114LP5DETR are nickel palladium gold (NiPdAu).

⁵ The HMC1114LP5DE and HMC1114LP5DETR four-digit lot number is represented by XXXX.